Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/005,164	OONO ET AL.
Examiner	Art Unit
Chong H. Kim	3682

SEARCHED					
Class	Subclass	Date	Examiner		
	•				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
search	all prev.	9/28/2005	СК		
		; :			
			i l		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated the search EAST text search	9/17/2005	CK
•		
	-	